



PSMN011-30YLC

N-channel 30 V 11.6 mΩ logic level MOSFET in LPAK using NextPower technology

Rev. 3 — 24 October 2011

Product data sheet

1. Product profile

1.1 General description

Logic level enhancement mode N-channel MOSFET in LPAK package. This product is designed and qualified for use in a wide range of industrial, communications and domestic equipment.

1.2 Features and benefits

- High reliability Power SO8 package, qualified to 175 °C
- Low parasitic inductance and resistance
- Optimised for 4.5V Gate drive utilising NextPower Superjunction technology
- Ultra low QG, QGD, & QOSS for high system efficiencies at low and high loads

1.3 Applications

- DC-to-DC converters
- Load switching
- Synchronous buck regulator

1.4 Quick reference data

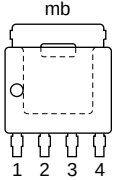
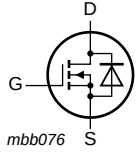
Table 1. Quick reference data

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
V _{DS}	drain-source voltage	25 °C ≤ T _j ≤ 175 °C	-	-	30	V
I _D	drain current	T _{mb} = 25 °C; V _{GS} = 10 V; see Figure 1	-	-	37	A
P _{tot}	total power dissipation	T _{mb} = 25 °C; see Figure 2	-	-	29	W
T _j	junction temperature		-55	-	175	°C
Static characteristics						
R _{DSon}	drain-source on-state resistance	V _{GS} = 4.5 V; I _D = 10 A; T _j = 25 °C; see Figure 12	-	12.3	14.5	mΩ
		V _{GS} = 10 V; I _D = 10 A; T _j = 25 °C; see Figure 12	-	9.9	11.6	mΩ
Dynamic characteristics						
Q _{GD}	gate-drain charge	V _{GS} = 4.5 V; I _D = 10 A; V _{DS} = 15 V; see Figure 14 ; see Figure 15	-	1.4	-	nC
Q _{G(tot)}	total gate charge	V _{GS} = 4.5 V; I _D = 10 A; V _{DS} = 15 V; see Figure 14 ; see Figure 15	-	4.9	-	nC



2. Pinning information

Table 2. Pinning information

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	S	source		
2	S	source		
3	S	source		
4	G	gate		
mb	D	mounting base; connected to drain		

SOT669 (LPAK; Power-SO8)

3. Ordering information

Table 3. Ordering information

Type number	Package		
	Name	Description	Version
PSMN011-30YLC	LPAK; Power-SO8	plastic single-ended surface-mounted package; 4 leads	SOT669

4. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V_{DS}	drain-source voltage	$25\text{ °C} \leq T_j \leq 175\text{ °C}$	-	30	V
V_{DGR}	drain-gate voltage	$25\text{ °C} \leq T_j \leq 175\text{ °C}$; $R_{GS} = 20\text{ k}\Omega$	-	30	V
V_{GS}	gate-source voltage		-20	20	V
I_D	drain current	$V_{GS} = 10\text{ V}$; $T_{mb} = 25\text{ °C}$; see Figure 1	-	37	A
		$V_{GS} = 10\text{ V}$; $T_{mb} = 100\text{ °C}$; see Figure 1	-	26	A
I_{DM}	peak drain current	pulsed; $t_p \leq 10\text{ }\mu\text{s}$; $T_{mb} = 25\text{ °C}$; see Figure 4	-	150	A
P_{tot}	total power dissipation	$T_{mb} = 25\text{ °C}$; see Figure 2	-	29	W
T_{stg}	storage temperature		-55	175	°C
T_j	junction temperature		-55	175	°C
$T_{sld(M)}$	peak soldering temperature		-	260	°C
V_{ESD}	electrostatic discharge voltage	MM (JEDEC JESD22-A115)	140	-	V

Source-drain diode

I_S	source current	$T_{mb} = 25\text{ °C}$	-	26	A
I_{SM}	peak source current	pulsed; $t_p \leq 10\text{ }\mu\text{s}$; $T_{mb} = 25\text{ °C}$	-	150	A

Avalanche ruggedness

$E_{DS(AL)S}$	non-repetitive drain-source avalanche energy	$V_{GS} = 10\text{ V}$; $T_{j(init)} = 25\text{ °C}$; $I_D = 37\text{ A}$; $V_{sup} \leq 30\text{ V}$; $R_{GS} = 50\text{ }\Omega$; unclamped; see Figure 3	-	9	mJ
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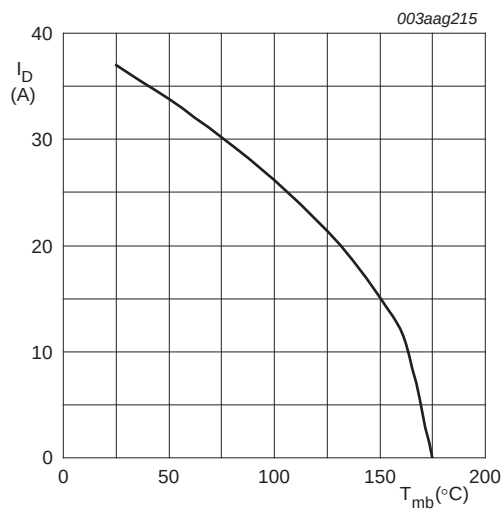


Fig 1. Continuous drain current as a function of mounting base temperature

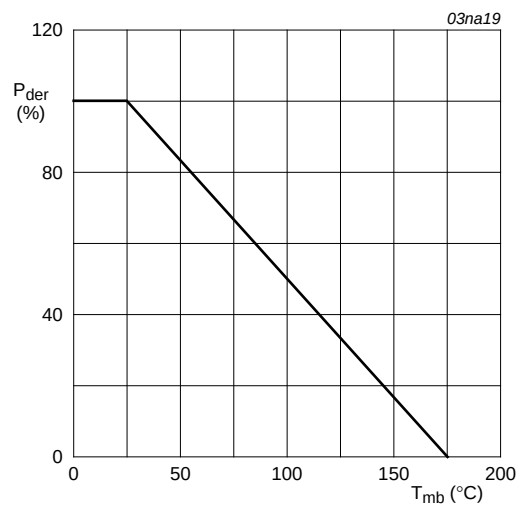
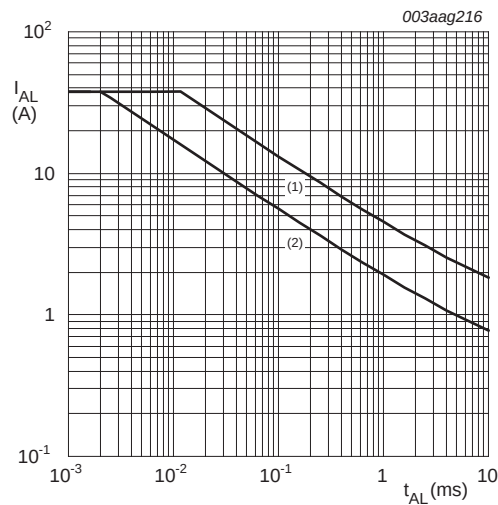
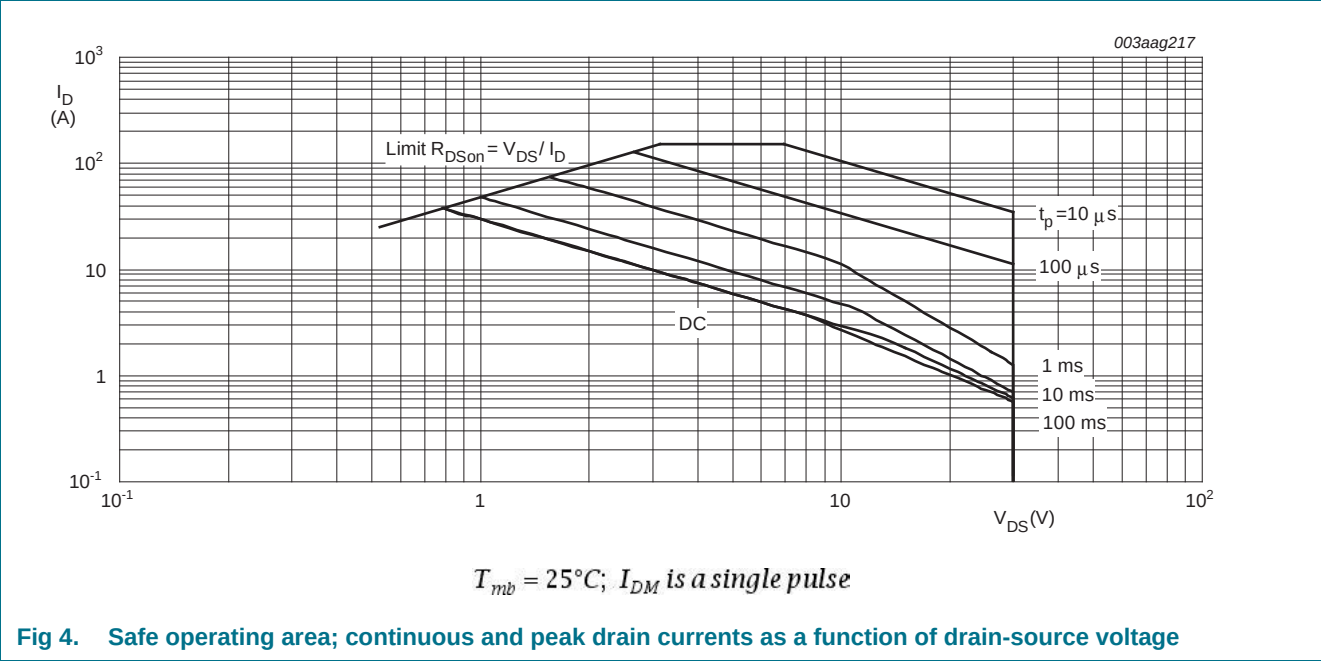


Fig 2. Normalized total power dissipation as a function of mounting base temperature



(1) $T_j (init) = 25^\circ C$; (2) $T_j (init) = 100^\circ C$

Fig 3. Single pulse avalanche rating; avalanche current as a function of avalanche time



5. Thermal characteristics

Table 5. Thermal characteristics

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$R_{th(j-mb)}$	thermal resistance from junction to mounting base	see Figure 5	-	4.87	5.06	K/W

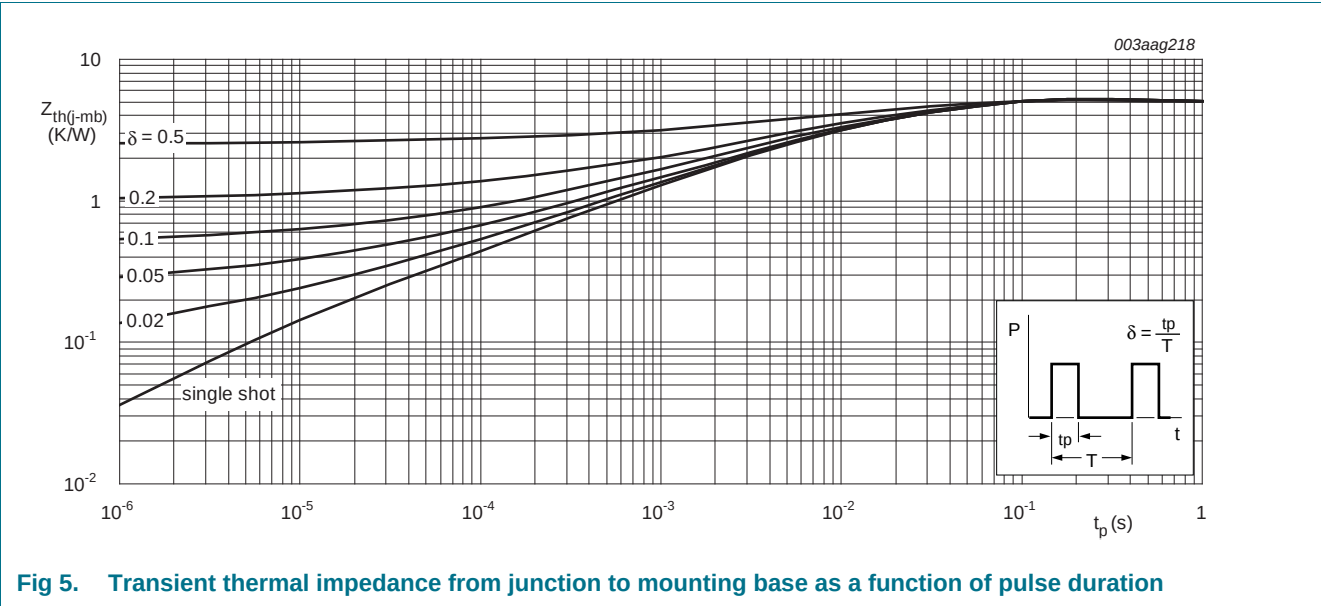


Fig 5. Transient thermal impedance from junction to mounting base as a function of pulse duration

6. Characteristics

Table 6. Characteristics

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
Static characteristics						
$V_{(BR)DSS}$	drain-source breakdown voltage	$I_D = 250\ \mu\text{A}; V_{GS} = 0\ \text{V}; T_j = 25\ ^\circ\text{C}$	30	-	-	V
		$I_D = 250\ \mu\text{A}; V_{GS} = 0\ \text{V}; T_j = -55\ ^\circ\text{C}$	27	-	-	V
$V_{GS(th)}$	gate-source threshold voltage	$I_D = 1\ \text{mA}; V_{DS} = V_{GS}; T_j = 25\ ^\circ\text{C};$ see Figure 10 ; see Figure 11	1.05	1.57	1.95	V
		$I_D = 10\ \text{mA}; V_{DS} = V_{GS}; T_j = 150\ ^\circ\text{C}$	0.5	-	-	V
		$I_D = 1\ \text{mA}; V_{DS} = V_{GS}; T_j = -55\ ^\circ\text{C}$	-	-	2.25	V
I_{DSS}	drain leakage current	$V_{DS} = 30\ \text{V}; V_{GS} = 0\ \text{V}; T_j = 25\ ^\circ\text{C}$	-	-	1	μA
		$V_{DS} = 30\ \text{V}; V_{GS} = 0\ \text{V}; T_j = 150\ ^\circ\text{C}$	-	-	100	μA
I_{GSS}	gate leakage current	$V_{GS} = 16\ \text{V}; V_{DS} = 0\ \text{V}; T_j = 25\ ^\circ\text{C}$	-	-	100	nA
		$V_{GS} = -16\ \text{V}; V_{DS} = 0\ \text{V}; T_j = 25\ ^\circ\text{C}$	-	-	100	nA
$R_{DS(on)}$	drain-source on-state resistance	$V_{GS} = 4.5\ \text{V}; I_D = 10\ \text{A}; T_j = 25\ ^\circ\text{C};$ see Figure 12	-	12.3	14.5	mΩ
		$V_{GS} = 4.5\ \text{V}; I_D = 10\ \text{A}; T_j = 150\ ^\circ\text{C};$ see Figure 12 ; see Figure 13	-	-	23.4	mΩ
		$V_{GS} = 10\ \text{V}; I_D = 10\ \text{A}; T_j = 25\ ^\circ\text{C};$ see Figure 12	-	9.9	11.6	mΩ
		$V_{GS} = 10\ \text{V}; I_D = 10\ \text{A}; T_j = 150\ ^\circ\text{C};$ see Figure 12 ; see Figure 13	-	-	18.8	mΩ
R_G	gate resistance	$f = 1\ \text{MHz}$	-	2	4	Ω
Dynamic characteristics						
$Q_{G(tot)}$	total gate charge	$I_D = 10\ \text{A}; V_{DS} = 15\ \text{V}; V_{GS} = 10\ \text{V};$ see Figure 14 ; see Figure 15	-	10.3	-	nC
		$I_D = 10\ \text{A}; V_{DS} = 15\ \text{V}; V_{GS} = 4.5\ \text{V};$ see Figure 14 ; see Figure 15	-	4.9	-	nC
		$I_D = 0\ \text{A}; V_{DS} = 0\ \text{V}; V_{GS} = 10\ \text{V}$	-	9	-	nC
Q_{GS}	gate-source charge	$I_D = 10\ \text{A}; V_{DS} = 15\ \text{V}; V_{GS} = 4.5\ \text{V};$ see Figure 14 ; see Figure 15	-	1.5	-	nC
$Q_{GS(th)}$	pre-threshold gate-source charge		-	1.1	-	nC
$Q_{GS(th-pl)}$	post-threshold gate-source charge		-	0.4	-	nC
Q_{GD}	gate-drain charge		-	1.4	-	nC
$V_{GS(pl)}$	gate-source plateau voltage	$I_D = 10\ \text{A}; V_{DS} = 15\ \text{V};$ see Figure 14 ; see Figure 15	-	2.5	-	V
C_{iss}	input capacitance	$V_{DS} = 15\ \text{V}; V_{GS} = 0\ \text{V}; f = 1\ \text{MHz};$ $T_j = 25\ ^\circ\text{C};$ see Figure 16	-	641	-	pF
C_{oss}	output capacitance		-	146	-	pF
C_{rss}	reverse transfer capacitance		-	46	-	pF
$t_{d(on)}$	turn-on delay time	$V_{DS} = 15\ \text{V}; R_L = 0.6\ \Omega; V_{GS} = 4.5\ \text{V};$ $R_{G(ext)} = 4.7\ \Omega$	-	13.4	-	ns
t_r	rise time		-	12.7	-	ns
$t_{d(off)}$	turn-off delay time		-	16.8	-	ns
t_f	fall time		-	6.6	-	ns

Table 6. Characteristics ...continued

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
Q_{oss}	output charge	$V_{GS} = 0\text{ V}$; $V_{DS} = 15\text{ V}$; $f = 1\text{ MHz}$; $T_j = 25\text{ °C}$	-	3.8	-	nC
Source-drain diode						
V_{SD}	source-drain voltage	$I_S = 10\text{ A}$; $V_{GS} = 0\text{ V}$; $T_j = 25\text{ °C}$; see Figure 17	-	0.85	1.1	V
t_{rr}	reverse recovery time	$I_S = 10\text{ A}$; $dI_S/dt = -100\text{ A/}\mu\text{s}$;	-	17	-	ns
Q_r	recovered charge	$V_{GS} = 0\text{ V}$; $V_{DS} = 15\text{ V}$	-	7	-	nC
t_a	reverse recovery rise time	$V_{GS} = 0\text{ V}$; $I_S = 10\text{ A}$;	-	10	-	ns
t_b	reverse recovery fall time	$dI_S/dt = -100\text{ A/}\mu\text{s}$; $V_{DS} = 15\text{ V}$; see Figure 18	-	7	-	ns

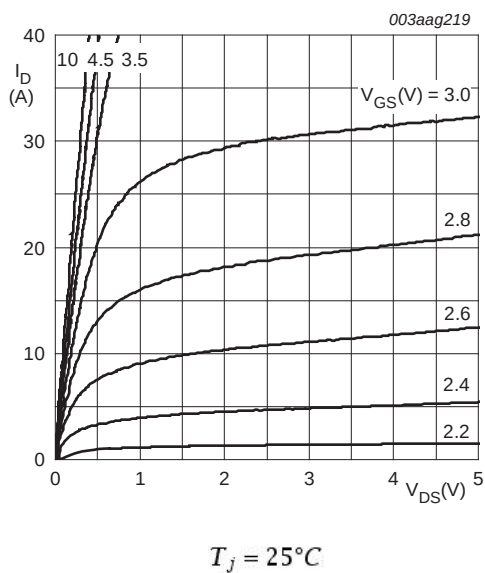


Fig 6. Output characteristics; drain current as a function of drain-source voltage; typical values

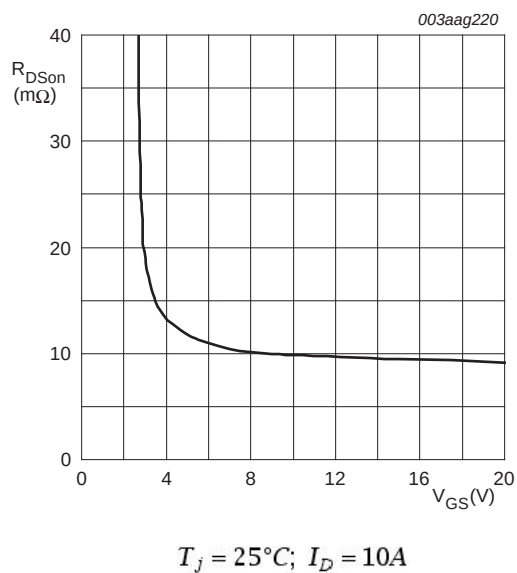
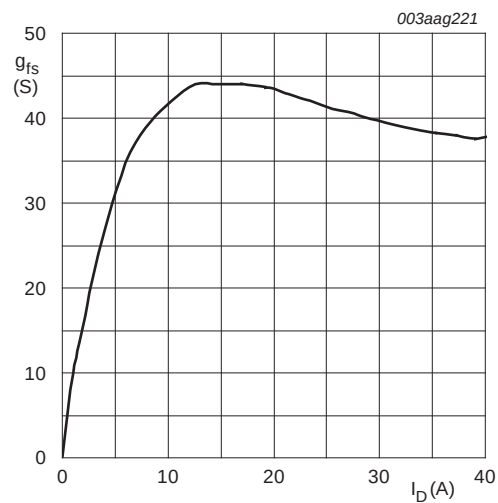
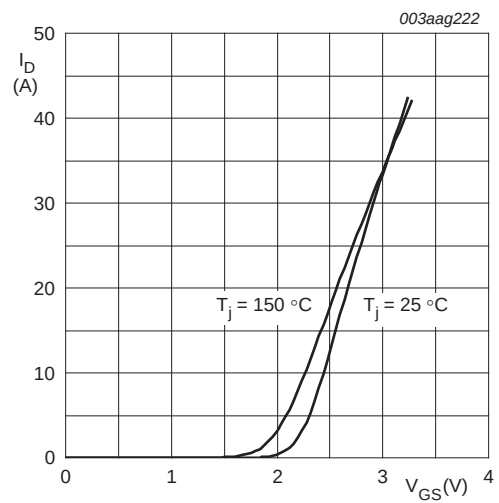


Fig 7. Drain-source on-state resistance as a function of gate-source voltage; typical values



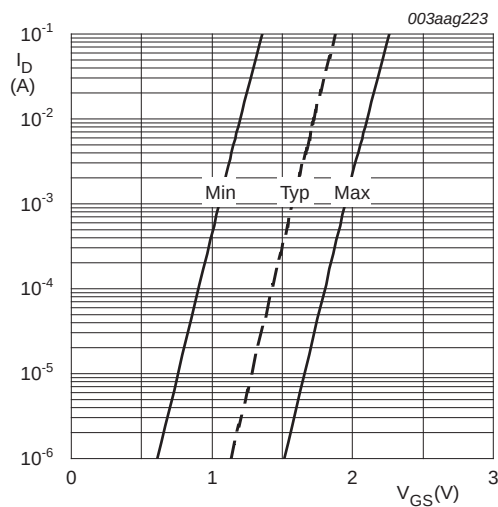
$T_J = 25^{\circ}\text{C}; V_{DS} = 10\text{V}$

Fig 8. Forward transconductance as a function of drain current; typical values



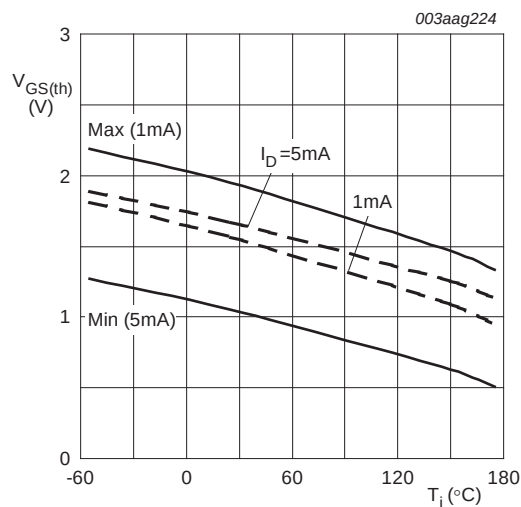
$V_{DS} = 10\text{V}$

Fig 9. Transfer characteristics; drain current as a function of gate-source voltage; typical values



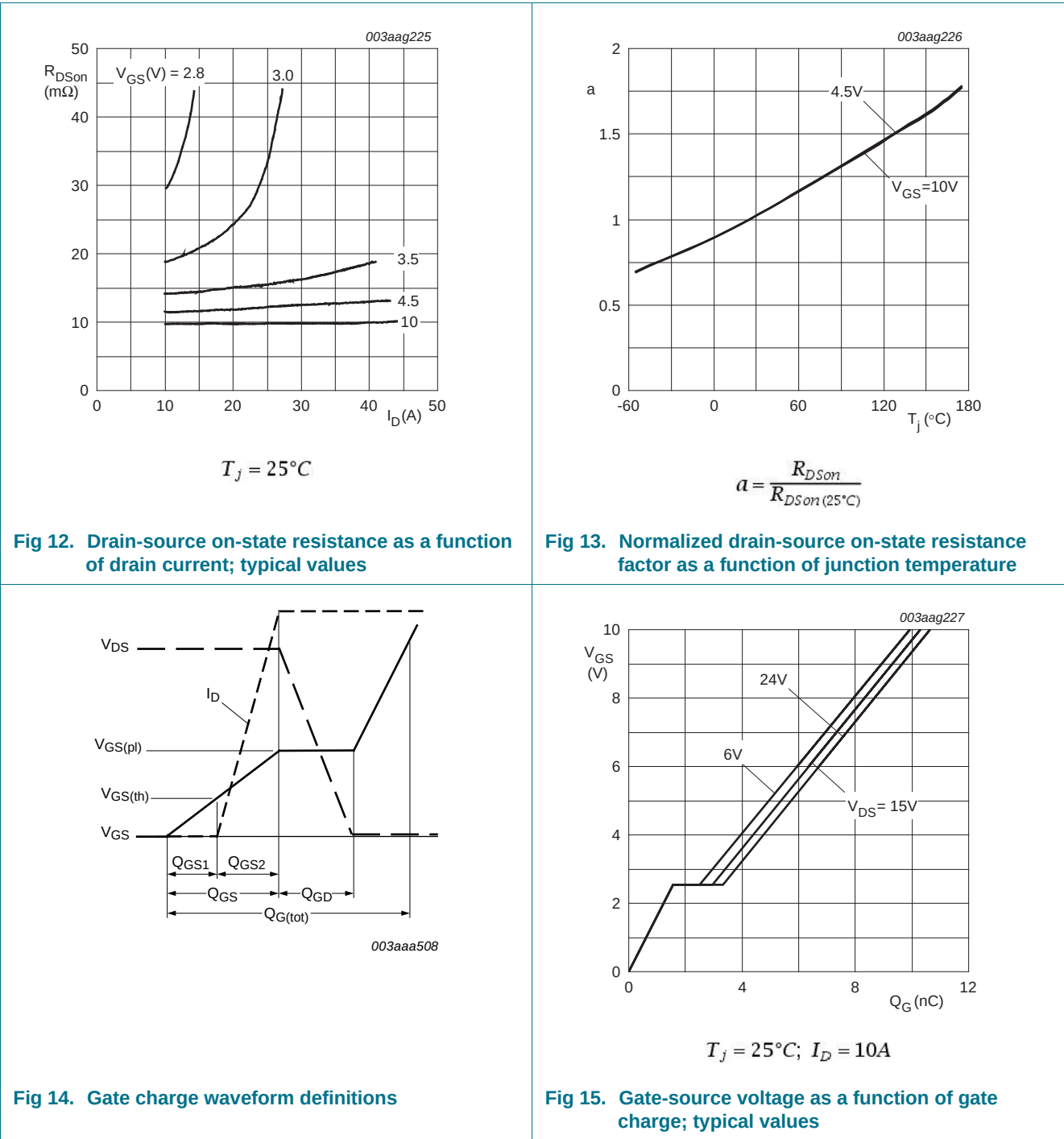
$T_J = 25^{\circ}\text{C}; V_{DS} = 5\text{V}$

Fig 10. Sub-threshold drain current as a function of gate-source voltage



$V_{DS} = V_{GS}$

Fig 11. Gate-source threshold voltage as a function of junction temperature



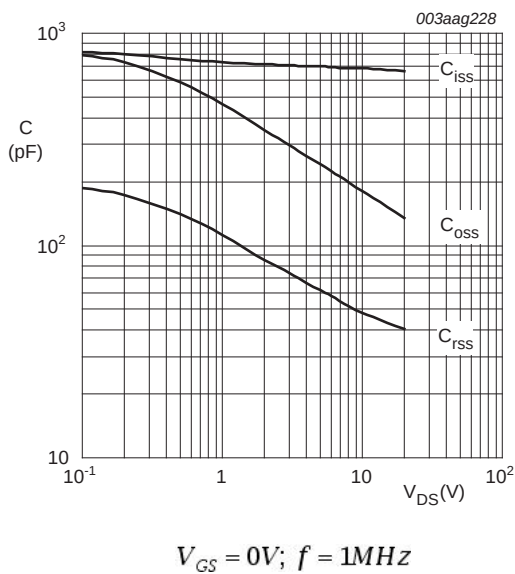


Fig 16. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values

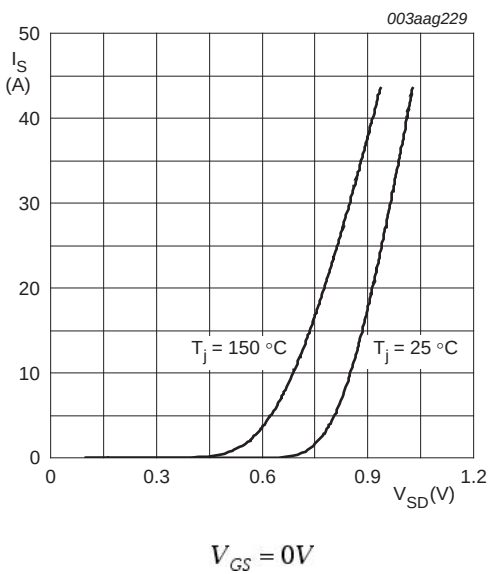


Fig 17. Source current as a function of source-drain voltage; typical values

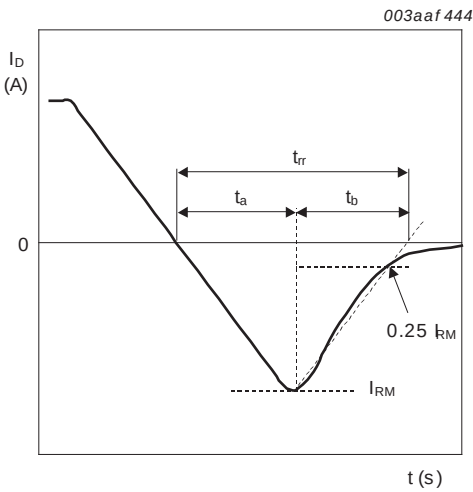


Fig 18. Reverse recovery timing definition

7. Package outline

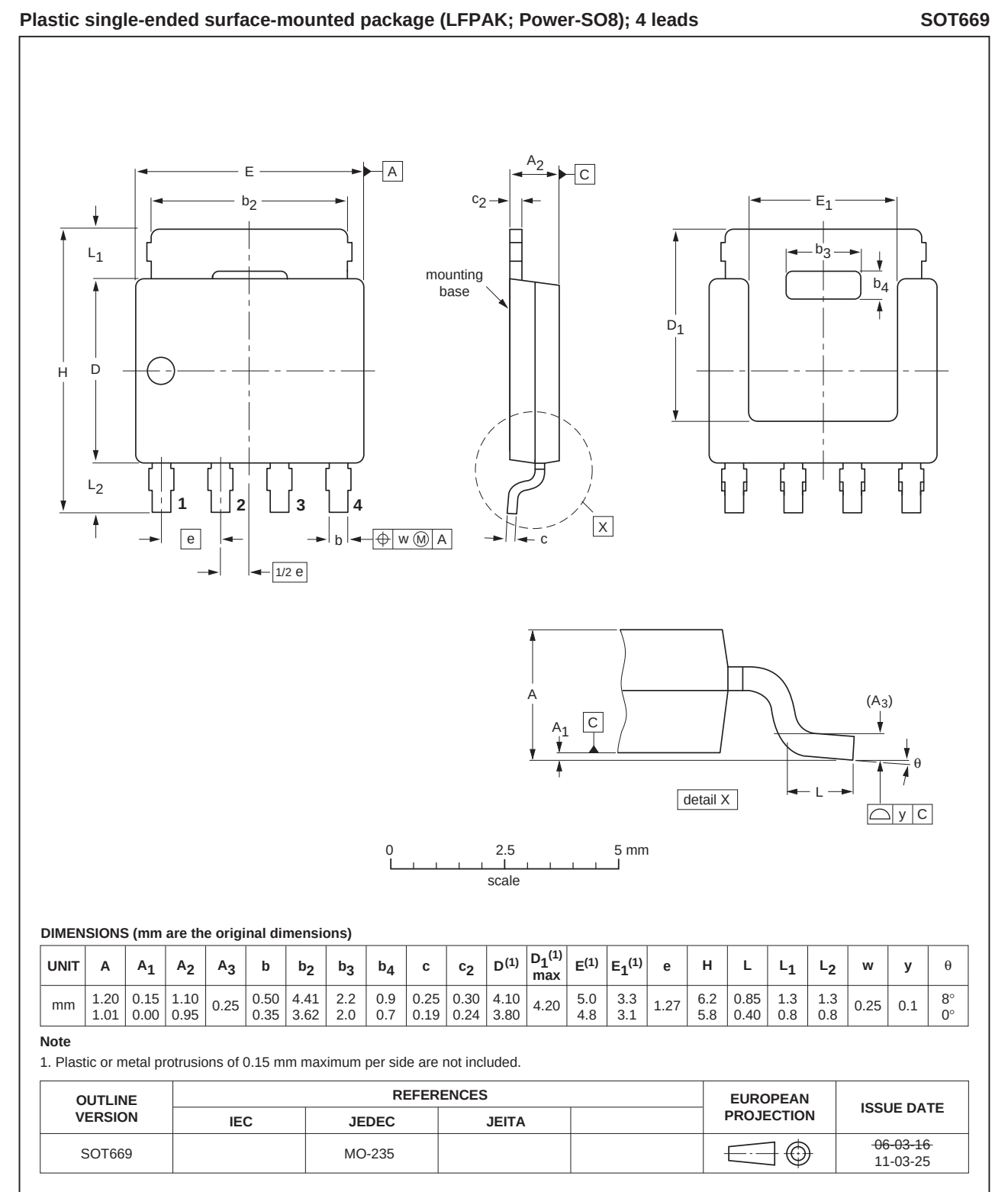


Fig 19. Package outline SOT669 (LPAK; Power-SO8)

8. Revision history

Table 7. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
PSMN011-30YLC v.3	20111024	Product data sheet	-	PSMN011-30YLC v.2
Modifications:	• Data sheet status changed from preliminary to product. • Various changes to content.			
PSMN011-30YLC v.2	20110930	Preliminary data sheet	-	PSMN011-30YLC v.1

9. Legal information

9.1 Data sheet status

Document status ^{[1] [2]}	Product status ^[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

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